

DK-59030-M1-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE)

CB TEST CERTIFICATE

Product DC/DC Power Module

Name and address of the applicant MINMAX TECHNOLOGY CO LTD

18 SIN-SIN RD AN-PING INDUSTRIAL DISTRICT TAINAN CITY

702 TAIWAN

Name and address of the manufacturer MINMAX TECHNOLOGY CO LTD

18 SIN-SIN RD AN-PING INDUSTRIAL DISTRICT TAINAN CITY

702 TAIWAN

Name and address of the factory MINMAX TECHNOLOGY CO LTD.

18 SIN-SIN RD AN-PING INDUSTRIAL DISTRICT TAINAN CITY Note: When more than one factory, please report on page 2

702 TAIWAN

Additional Information on page 2

Ratings and principal characteristics (Optional)

Input: 3.3 Vdc (tolerance 2.97-3.63 Vdc), 390 mA for models:

MAPU01-033S033H, MAPU01-033S033HA

see test report for details.

Trademark (if any) <>MINMAX® "MINMAX®

Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref. MAPU01-xyH, MAPU01-xyHA, MSPU01-zaH, MSPU01-zaH-W,

and MFPU01-zaH See Page 2

Additional information (if necessary may also be reported on page 2)

Additional Information on page 2

A sample of the product was tested and found to be in conformity with

IEC 62368-1(ed.2)

As shown in the Test Report Ref. No. which forms part

of this Certificate

1803013-1-CB-M1 issued on 2018-06-13

This CB Test Certificate is issued by the National Certification Body



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK

UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN

UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2018-06-20 Original Issue Date: 2016-11-01 Signature:

Jan-Erik Storgaard



DK-59030-M1-UL

Model Details:

MAPU01-xyH, MAPU01-xyHA, MSPU01-zaH, MSPU01-zaH-W, and MFPU01-zaH (x can be 033, 05, 12 or 24; y can be S033, S05, S09, S12, S15, D05, D12 or D15; a can be S033, S05, S12, S15, D05, D12 or D15; z can be 033, 05 or 12)

Additional Information:

Additionally evaluated to EN 62368-1:2014 /A11:2017; National Difference specified in the CB Test Report The original report was modified to include the following changes/additions:

- 1. Output pins reassignment for series Models MAPU01-xyH and MAPU01-xyHA, the PWB layout, schematic and T1 minor changed. Update Enclosures.
- 2. Addition Models MAPU01-xyHA
- 3. Update European group differences
- 4. Changed to Pollution Degree to 3 from 2.
- 5. Addition description for different input voltage to match Transistors (Q1, Q2)
- 6. Update ID 7-01 rating list

Additional information (if necessary)



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